Se	arcn	notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/087,888	NAISMITH ET AL.	H ET AL.
Examiner	Art Unit	
Dustin Nauven	2154	

	CEAD	CHED	
	SEAR	CHED	
Class	Subclass	Date	Examiner
709	207, 208, 227, 250	3/15/2007	DN
370	313	3/15/2007	DN
700	5	3/15/2007	DN
710 ·	8, 15	3/15/2007	DN
713	1	3/15/2007	DN
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
search EAST, parent case	3/15/2007	DN
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